

# CGHV22150MP

**150 W, 1800-2200 MHz, 50 V, GaN HEMT for LTE**

Cree's CGHV22150MP is a gallium nitride (GaN) high electron mobility transistor (HEMT) is designed specifically for high efficiency, high gain and wide bandwidth capabilities, which makes the CGHV22150MP ideal for 1.8 - 2.2 GHz LTE, 4G Telecom and BWA amplifier applications. The transistor is input matched and supplied in an overmold flange package.



PN: CGHV22150MP

## Typical Performance Over 2.11 - 2.17 GHz ( $\tau_c = 25^\circ\text{C}$ ) of Demonstration Amplifier

Parameter	2.11 GHz	2.14 GHz	2.17 GHz	Units
Gain @ 45 dBm	18.5	18.8	19.0	dB
ACLR @ 45 dBm	-36.2	-35.0	-33.8	dBc
Drain Efficiency @ 45 dBm	30.9	32.0	33.3	%

**Note:**

Measured in the CGHV22150MP-TB amplifier circuit, under WCDMA 3GPP test model 1, 64 DPCH, 45% clipping, PAR = 7.5 dB @ 0.01% Probability on CCDF,  $V_{DD} = 50\text{ V}$ ,  $I_{DS} = 625\text{ mA}$ .

## Features

- 1.8 - 2.2 GHz Operation
- 19 dB Gain
- 30 W Average Output Power
- -35 dBc ACLR at 30 W  $P_{AVE}$
- 32% Efficiency at 30 W  $P_{AVE}$
- High Degree of DPD Correction Can be Applied





## Absolute Maximum Ratings (not simultaneous)

Parameter	Symbol	Rating	Units	Conditions
Drain-Source Voltage	$V_{DS}$	125	Volts	25 °C
Gate-to-Source Voltage	$V_{GS}$	-10, +2	Volts	25 °C
Storage Temperature	$T_{STG}$	-65, +150	°C	
Operating Junction Temperature	$T_J$	225	°C	
Maximum Forward Gate Current	$I_{GMAX}$	20	mA	25 °C
Maximum Drain Current <sup>1</sup>	$I_{DMAX}$	7.5	A	25 °C
Soldering Temperature <sup>2</sup>	$T_S$	245	°C	
Thermal Resistance, Junction to Case <sup>3</sup>	$R_{\theta JC}$	1.92	°C/W	85 °C, $P_{DISS} = 60$ W
Case Operating Temperature <sup>4</sup>	$T_C$	-40, +150	°C	

Note:

<sup>1</sup> Current limit for long term, reliable operation.

<sup>2</sup> Refer to the Application Note on soldering at <http://www.cree.com/rf/document-library>

<sup>3</sup> Measured for the CGHV22150MP

<sup>4</sup> See also, the Power Dissipation De-rating Curve on Page 4.

## Electrical Characteristics ( $T_C = 25^\circ\text{C}$ )

Characteristics	Symbol	Min.	Typ.	Max.	Units	Conditions
<b>DC Characteristics<sup>1</sup></b>						
Gate Threshold Voltage	$V_{GS(th)}$	-3.8	-3.0	-2.3	$V_{DC}$	$V_{DS} = 10$ V, $I_D = 16$ mA
Gate Quiescent Voltage	$V_{GS(Q)}$	-	-2.7	-	$V_{DC}$	$V_{DS} = 50$ V, $I_D = 625$ mA
Saturated Drain Current <sup>2</sup>	$I_{DS}$	15	18	-	A	$V_{DS} = 6.0$ V, $V_{GS} = 2.0$ V
Drain-Source Breakdown Voltage	$V_{BR}$	125	-	-	$V_{DC}$	$V_{GS} = -8$ V, $I_D = 16$ mA
<b>RF Characteristics<sup>5</sup> (<math>T_C = 25^\circ\text{C}</math>, <math>F_0 = 2.14</math> GHz unless otherwise noted)</b>						
Saturated Output Power <sup>3,4</sup>	$P_{SAT}$	-	170	-	W	$V_{DD} = 50$ V, $I_{DQ} = 625$ mA
Pulsed Drain Efficiency <sup>3,4</sup>	$\eta$	-	70	-	%	$V_{DD} = 50$ V, $I_{DQ} = 625$ mA, $P_{OUT} = P_{SAT}$
Gain <sup>6</sup>	G	-	19	-	dB	$V_{DD} = 50$ V, $I_{DQ} = 625$ mA, $P_{OUT} = 45$ dBm
WCDMA Linearity <sup>6</sup>	ACLR	-	-35	-	dBc	$V_{DD} = 50$ V, $I_{DQ} = 625$ mA, $P_{OUT} = 45$ dBm
Drain Efficiency <sup>6</sup>	$\eta$	-	32	-	%	$V_{DD} = 50$ V, $I_{DQ} = 625$ mA, $P_{OUT} = 45$ dBm
Output Mismatch Stress <sup>3</sup>	VSWR	-	-	10 : 1	$\Psi$	No damage at all phase angles, $V_{DD} = 50$ V, $I_{DQ} = 625$ mA, $P_{OUT} = 150$ W Pulsed
<b>Dynamic Characteristics</b>						
Input Capacitance <sup>7</sup>	$C_{GS}$	-	-	-	pF	$V_{DS} = 50$ V, $V_{GS} = -8$ V, $f = 1$ MHz
Output Capacitance <sup>7</sup>	$C_{DS}$	-	-	-	pF	$V_{DS} = 50$ V, $V_{GS} = -8$ V, $f = 1$ MHz
Feedback Capacitance	$C_{GD}$	-	-	-	pF	$V_{DS} = 50$ V, $V_{GS} = -8$ V, $f = 1$ MHz

Notes:

<sup>1</sup> Measured on wafer prior to packaging.

<sup>2</sup> Scaled from PCM data.

<sup>3</sup> Pulse Width = 100  $\mu$ s, Duty Cycle = 10%

<sup>4</sup>  $P_{SAT}$  is defined as  $I_{GS} = 2.0$  mA peak

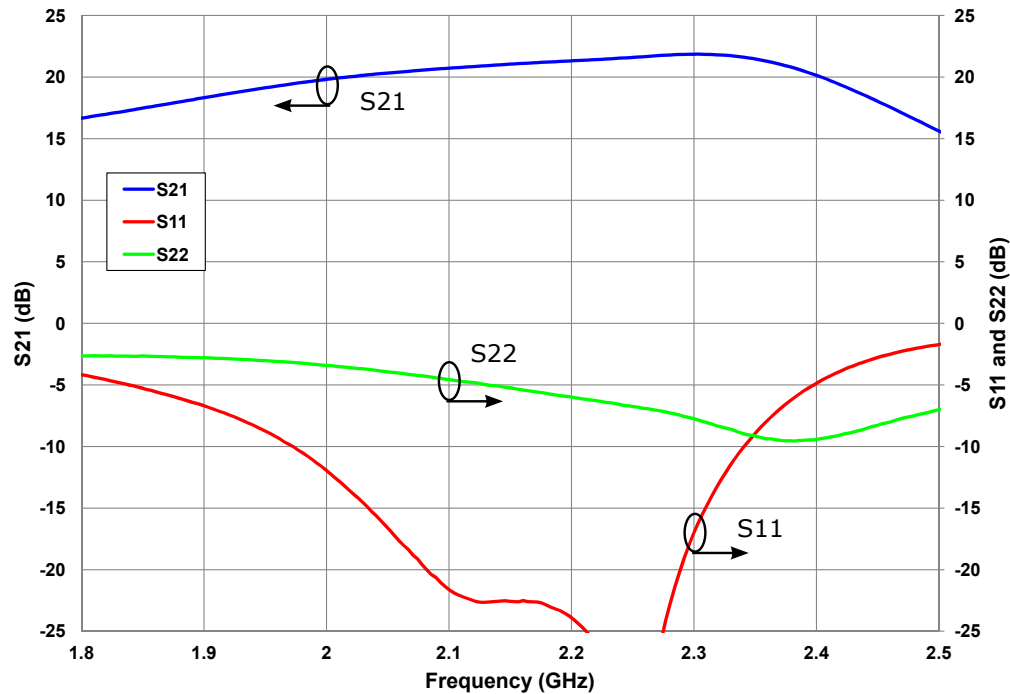
<sup>5</sup> Measured in CGHV22150MP-TB.

<sup>6</sup> Single Carrier WCDMA, 3GPP Test Model 1, 64 DPCH, 45% Clipping, PAR = 7.5 dB @ 0.01% Probability on CCDF,  $V_{DD} = 50$  V.

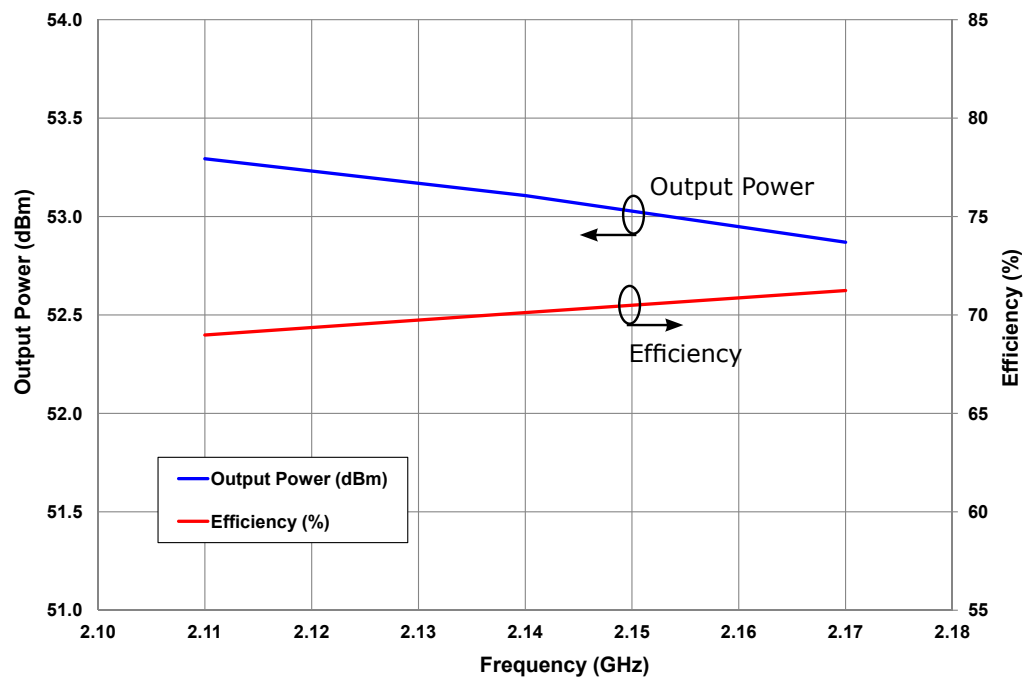
<sup>7</sup> Includes package and internal matching components.

## Typical Performance

**Figure 1. - Small Signal S-Parameters**  
 $V_{DD} = 50\text{ V}$ ,  $I_{DQ} = 0.625\text{ A}$

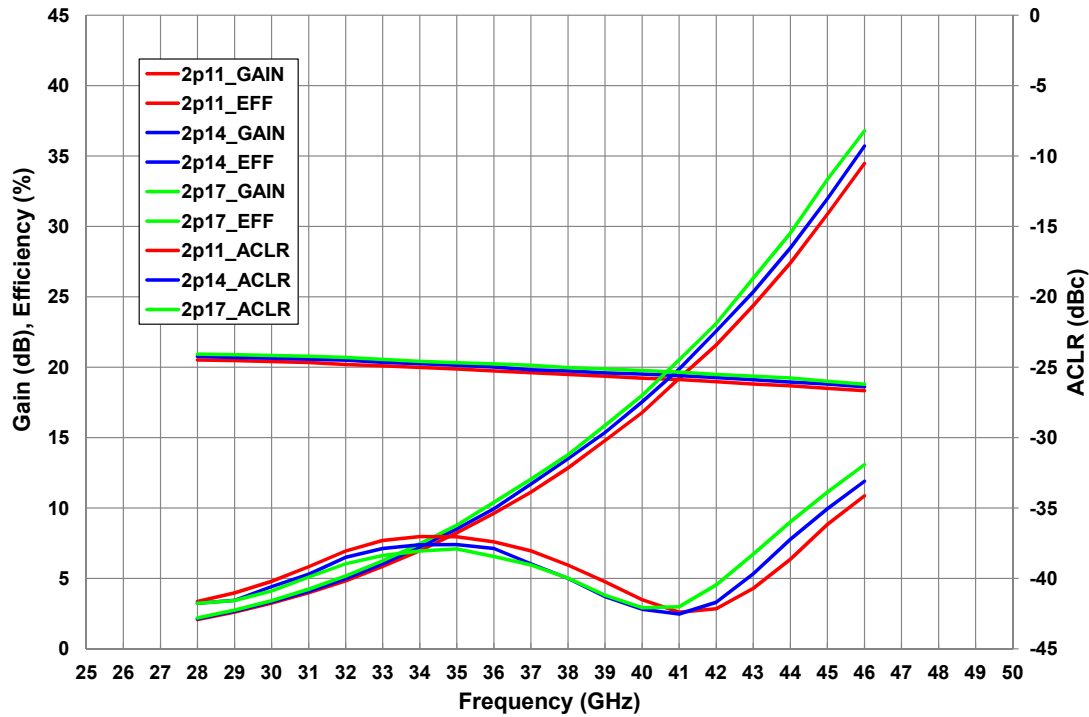


**Figure 2. - Typical  $P_{SAT}$  Power and Efficiency**  
 $V_{DD} = 50\text{ V}$ ,  $I_{DQ} = 0.625\text{ A}$ ,  $100\text{ }\mu\text{s}$ ,  $10\%$

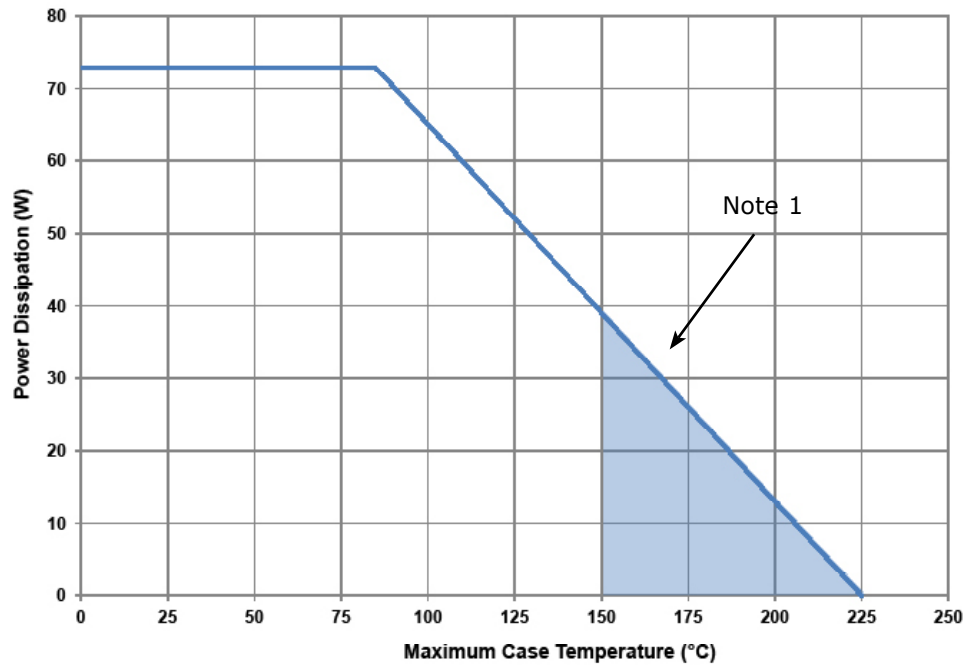


## Typical Performance

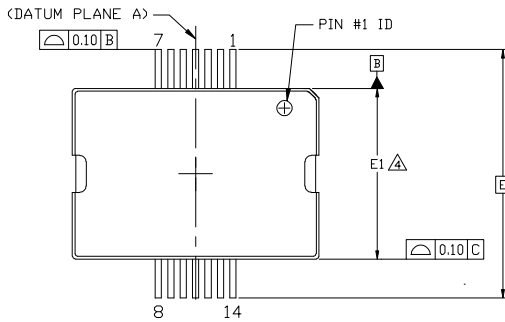
**Figure 3. - Typical Gain, Drain Efficiency and ACLR vs Frequency**  
 $V_{DD} = 50\text{ V}$ ,  $I_{DQ} = 0.625\text{ A}$ ,  $P_{AVE} = 30\text{ W}$ , 1c WCDMA, PAR = 7.5 dB



**Figure 4. - Power Dissipation Derating Curve**

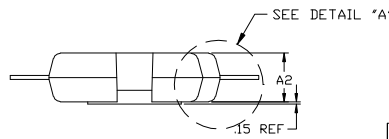
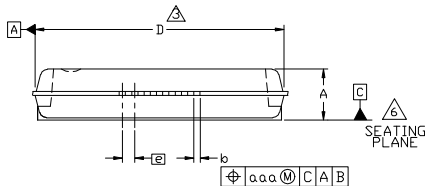


## Product Dimensions CGHV22150MP (Package Type)



### NOTES:

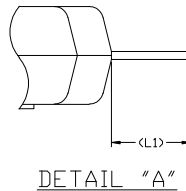
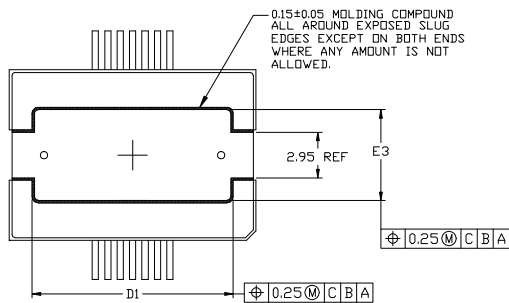
1. DIMENSIONING & TOLERANCES PER ANSI Y14.5M-1994.
2. "C" IS A REFERENCE DATUM.
3. DIMENSION "D" DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE.
4. DIMENSION "E1" DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.15 PER SIDE.
5. CONTROLLING DIMENSION: MILLIMETERS.
6. SEATING PLANE IS DEFINED BY BOTTOM OF HEAT SLUG.



PINOUT TABLE

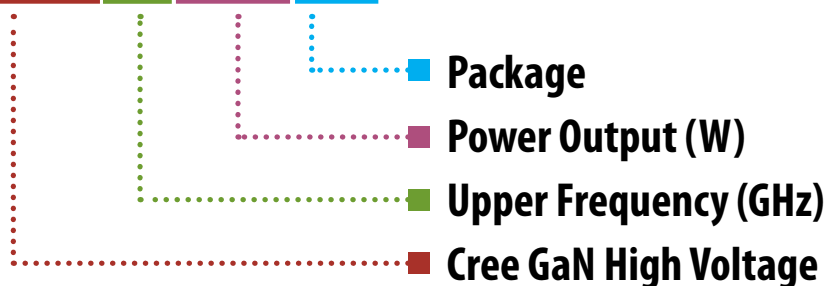
SYMBOL	COMMON DIMENSIONS			NOM. TOL.
	MIN.	NOM.	MAX.	
A	—	—	3.60	—
A1	0.10	0.20	0.30	—
A2	3.00	3.15	3.30	—
A3	0	0.05	0.10	—
aaa	—	0.20	—	—
b	0.35	—	0.48	—
D	—	15.90 BSC	—	3
D1	9.00	—	13.00	—
E	—	16.00 BSC	—	—
E1	—	11.00 BSC	—	4
E3	5.80	—	6.20	—
e	—	0.80 BSC	—	—
L1	—	2.54 REF	—	—

PIN	FUNCTION
1	RF INPUT
2	RF INPUT
3	RF INPUT
4	RF INPUT
5	RF INPUT
6	RF INPUT
7	RF INPUT
8	RF OUTPUT
9	RF OUTPUT
10	RF OUTPUT
11	RF OUTPUT
12	RF OUTPUT
13	RF OUTPUT
14	RF OUTPUT



## Part Number System

# CGHV22150MP



Parameter	Value	Units
Upper Frequency <sup>1</sup>	2.2	GHz
Power Output	150	W
Package	Plastic Overmold	-

**Table 1.**

**Note<sup>1</sup>:** Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Character Code	Code Value
A	0
B	1
C	2
D	3
E	4
F	5
G	6
H	7
J	8
K	9
Examples:	1A = 10.0 GHz 2H = 27.0 GHz

**Table 2.**



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